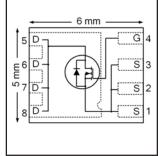


HEXFET® Power MOSFET

V _{DS}	100	V
R _{DS(on) max} (@ V _{GS} = 10V)	12.4	$\mathbf{m}\Omega$
Q _{g (typical)}	54	nC
R _{G (typical)}	1.5	Ω
I _D (@T _{c(Bottom)} = 25°C)	63	A





Applications

- Secondary Side Synchronous Rectification
- Inverters for DC Motors
- DC-DC Brick Applications

Features and Benefits

Features

Low RDSon (< 12.4 m Ω)	
Low Thermal Resistance to PCB (< 1.1°C/W)	
100% Rg tested	
Low Profile (<0.9 mm)	results ir
Industry-Standard Pinout	\Rightarrow
Compatible with Existing Surface Mount Techniques	
RoHS Compliant Containing no Lead, no Bromide and no Halogen	
MSL1, Industrial Qualification	
···	-

Benefits

	Lower Conduction Losses
	Increased Power Density
	Increased Reliability
n	Increased Power Density
	Multi-Vendor Compatibility
	Easier Manufacturing
	Environmentally Friendlier
	Increased Reliability

Outlevelte west south as	part number Package Type Standard Pack Form Quantity		d Pack	Note	
Orderable part number			Quantity	Note	
IRFH5110TRPbF	PQFN 5mm x 6mm	Tape and Reel	4000		
IRFH5110TR2PbF	PQFN 5mm x 6mm	Tape and Reel	400	EOL notice # 259	

Absolute Maximum Ratings

	Parameter	Max.	Units
V _{DS}	Drain-to-Source Voltage	100	V
V _{GS}	Gate-to-Source Voltage	± 20]
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V	11	
I _D @ T _A = 70°C	Continuous Drain Current, V _{GS} @ 10V	9.0	
I _D @ T _{C(Bottom)} = 25°C	Continuous Drain Current, V _{GS} @ 10V	63	Α
I _D @ T _{C(Bottom)} = 100°C	Continuous Drain Current, V _{GS} @ 10V	40	1
I _{DM}	Pulsed Drain Current ①	252	
P _D @T _A = 25°C	Power Dissipation ©	3.6	14/
P _D @ T _{C(Bottom)} = 25°C	Power Dissipation ®	114	W
	Linear Derating Factor ⑤	0.029	W/°C
T _J	Operating Junction and	-55 to + 150	°C
T _{STG}	Storage Temperature Range		

Notes ① through ⑤ are on page 9



Static @ $T_J = 25$ °C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_D = 250uA$
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.11		V/°C	Reference to 25°C, I _D = 1.0mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		10.3	12.4	mΩ	V _{GS} = 10V, I _D = 37A ③
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	V - V I - 100uA
$\Delta V_{GS(th)}$	Gate Threshold Voltage Coefficient		-8.8		mV/°C	$V_{DS} = V_{GS}, I_D = 100\mu A$
I _{DSS}	Drain-to-Source Leakage Current			20	μA	$V_{DS} = 100V, V_{GS} = 0V$
				250	μΑ	$V_{DS} = 100V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-100	I IIA	V _{GS} = -20V
gfs	Forward Transconductance	286			S	$V_{DS} = 25V, I_{D} = 37A$
Q_g	Total Gate Charge		54	81		
Q _{gs1}	Pre-Vth Gate-to-Source Charge		13			$V_{DS} = 50V$
Q _{gs2}	Post-Vth Gate-to-Source Charge		3.9		nC	V _{GS} = 10V
Q_gd	Gate-to-Drain Charge		15			$I_D = 37A$
Q _{godr}	Gate Charge Overdrive		22			
Q_{sw}	Switch Charge (Q _{gs2} + Q _{gd})		19			
Q _{oss}	Output Charge		14		nC	$V_{DS} = 16V, V_{GS} = 0V$
R_G	Gate Resistance		1.5		Ω	
t _{d(on)}	Turn-On Delay Time		7.8			$V_{DD} = 50V, V_{GS} = 10V$
t _r	Rise Time		9.6		1	$I_D = 37A$
t _{d(off)}	Turn-Off Delay Time	l	22		ns	$R_G=1.3\Omega$
t _f	Fall Time		6.4]	
C _{iss}	Input Capacitance		3152			$V_{GS} = 0V$
C _{oss}	Output Capacitance		324		pF	$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance	l	121		1	f = 1.0MHz

Avalanche Characteristics

	Parameter	Тур.	Max.	Units
E _{AS}	Single Pulse Avalanche Energy ②		93	mJ
IAR	Avalanche Current ①		37	Α

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current			63		MOSFET symbol
	(Body Diode)			03	-	showing the
I _{SM}	Pulsed Source Current			252	Α	integral reverse
	(Body Diode) ①			252		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C$, $I_S = 37A$, $V_{GS} = 0V$ ③
t _{rr}	Reverse Recovery Time		34	51	ns	$T_J = 25^{\circ}C$, $I_F = 37A$, $V_{DD} = 50V$
Q _{rr}	Reverse Recovery Charge		237	356	nC	di/dt = 500A/µs ③
t _{on}	Forward Turn-On Time	Time is	Time is dominated by parasitic Inductance			

Thermal Resistance

	Parameter	Тур.	Max.	Units
R _{eJC} (Bottom)	Junction-to-Case @		1.1	
R _{eJC} (Top)	Junction-to-Case ④		15	°C/W
$R_{\theta JA}$	Junction-to-Ambient ©		35	
R _{0JA} (<10s)	Junction-to-Ambient ©		22	



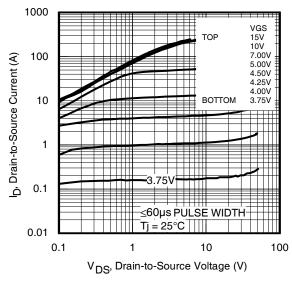


Fig 1. Typical Output Characteristics

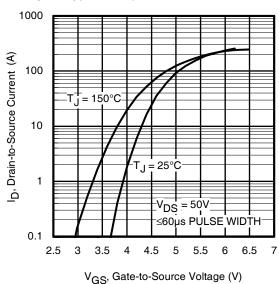
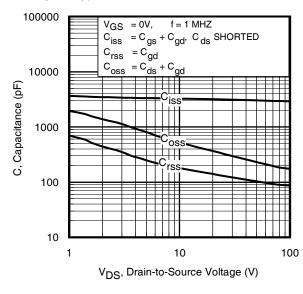


Fig 3. Typical Transfer Characteristics



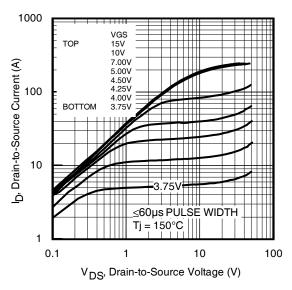


Fig 2. Typical Output Characteristics

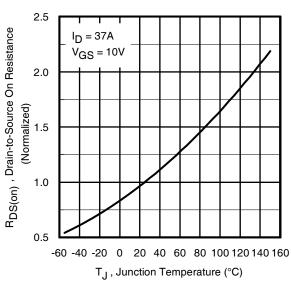


Fig 4. Normalized On-Resistance Vs. Temperature

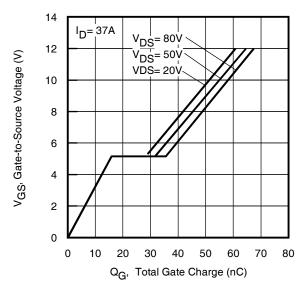


Fig 5. Typical Capacitance Vs.Drain-to-Source Voltage Fig 6. Typical Gate Charge Vs.Gate-to-Source Voltage

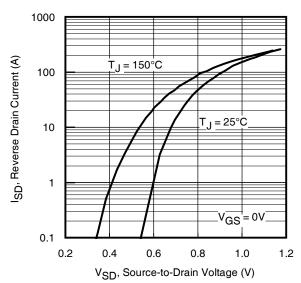


Fig 7. Typical Source-Drain Diode Forward Voltage

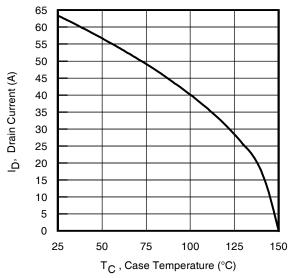


Fig 9. Maximum Drain Current Vs. Case (Bottom) Temperature

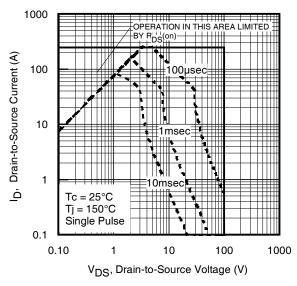


Fig 8. Maximum Safe Operating Area

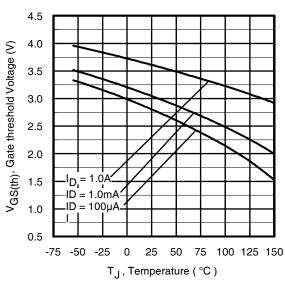


Fig 10. Threshold Voltage Vs. Temperature

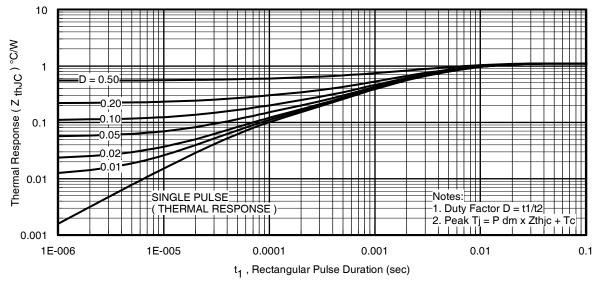


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case (Bottom)



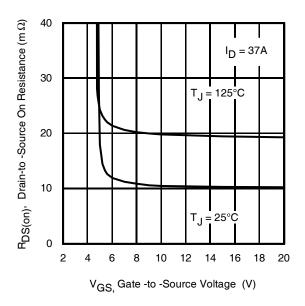


Fig 12. On-Resistance vs. Gate Voltage

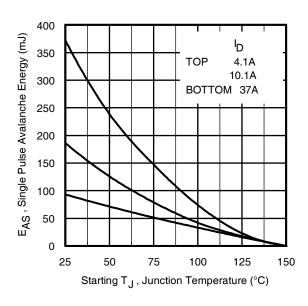


Fig 13. Maximum Avalanche Energy vs. Drain Current

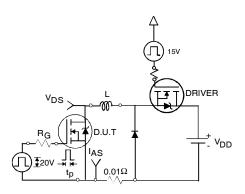


Fig 14a. Unclamped Inductive Test Circuit

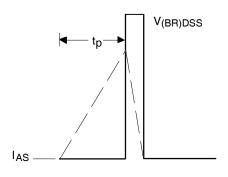


Fig 14b. Unclamped Inductive Waveforms

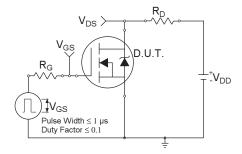


Fig 15a. Switching Time Test Circuit

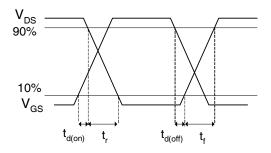


Fig 15b. Switching Time Waveforms

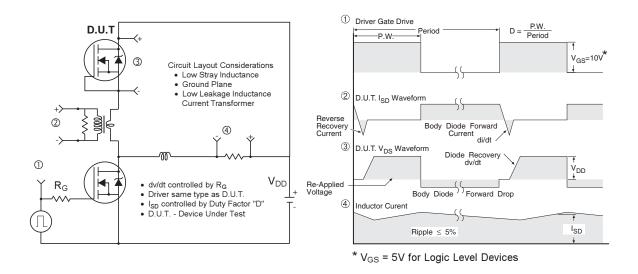
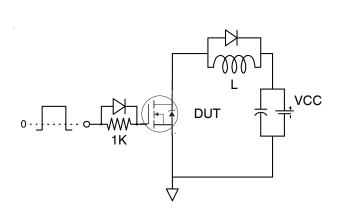


Fig 16. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs



Qgs1 Qgs2 Qgd Qgodr

Vds

Fig 17. Gate Charge Test Circuit

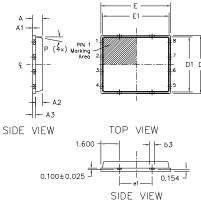
Fig 18. Gate Charge Waveform

ld

Vgs



PQFN 5x6 Outline "B" Package Details



SIDE VIEW
0.422 - K R2 - K 0.395 D2 6 - E4 - B0 (8x) Expose Pod - E2 - L (4x)
BOTTOM VIEW

DIM	MILLIMITERS		IN	СН
SYMBOL	MIN	MAX	MIN	MAX
А	0.800	0.900	0.0315	0.0543
A1	0.000	0.050	0.0000	0.0020
А3	0.20	0 REF	0.007	'9 REF
b	0.350	0.470	0.0138	0.0185
b1	0.025	0.125	0.0010	0.0049
b2	0.210	0.410	0.0083	0.0161
b3	0.150	0.450	0.0059	0.0177
D	5.00	O BSC	0.1969 BSC	
D1	4.75	O BSC	0.1870 BSC	
D2	4.100	4.300	0.1614	0.1693
E	6.00	O BSC	0.2362 BSC	
E1	5.75	0 BSC	0.2264 BSC	
E2	3.380	3.780	0.1331	0.1488
е	1.27	70 REF	0.05	OO REF
e1	2.80	00 REF	0.1102 RE	
K	1.200	1.420	0.0472	0.0559
L	0.710	0.900	0.0280	0.0354
Р	0°	12°	0°	12°
R	0.200	REF	0.007	9 REF
R2	0.150	0.200	0.0059	0.0079

Note:

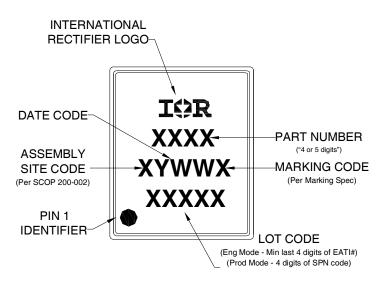
- Dimensions and toleranceing confirm to ASME Y14.5M-1994
- Dimension L represents terminal full back from package edge up to 0,1mm is acceptable
- Coplanarity applies to the expose Heat Slug as well as the terminal
- 4. Radius on terminal is Optional

For more information on board mounting, including footprint and stencil recommendation, please refer to application note AN-1136: http://www.irf.com/technical-info/appnotes/an-1136.pdf

For more information on package inspection techniques, please refer to application note AN-1154:

http://www.irf.com/technical-info/appnotes/an-1154.pdf

PQFN 5x6 Part Marking

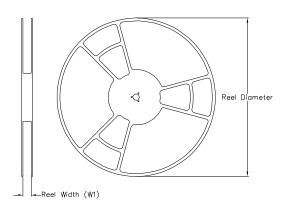


Note: For the most current drawing please refer to IR website at: http://www.irf.com/package/

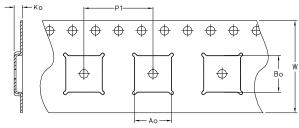


PQFN 5x6 Tape and Reel

REEL DIMENSIONS

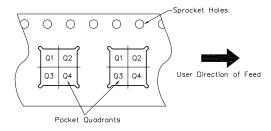


TAPE DIMENSIONS



CODE	DESCRIPTION
Ao	Dimension design to accommodate the component width
Во	Dimension design to accommodate the component lenght
Ко	Dimension design to accommodate the component thickness
W	Overall width of the carrier tape
Pη	Pitch between successive conity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Note: All dimension are nominal

Paakage Type	Reel Diameter (Inch)	QTY	Ræl Width W1 (mm)	Ao (mm)	Bo (mm)	Ko (mm)	P1 (mm)	W (mm)	Pin 1 Quadrant
5 X 6 PQFN	13	4000	12.4	6.300	5.300	1.20	8.00	12	Ql

Note: For the most current drawing please refer to IR website at: http://www.irf.com/package/



Qualification information[†]

Qualification level	Industrial ^{††} (per JEDEC JES D47F ^{†††} guidelines)				
Moisture Sensitivity Level	PQFN 5mm x 6mm	MSL1 (per JEDEC J-STD-020D ^{†††})			
RoHS compliant	Yes				

- † Qualification standards can be found at International Rectifier's web site http://www.irf.com/product-info/reliability
- †† Higher qualification ratings may be available should the user have such requirements. Please contact your International Rectifier sales representative for further information: http://www.irf.com/whoto-call/salesrep/
- **†††** Applicable version of JEDEC standard at the time of product release.

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting $T_J = 25$ °C, L = 0.136mH, $R_G = 50\Omega$, $I_{AS} = 37$ A.
- 3 Pulse width \leq 400 μ s; duty cycle \leq 2%.
- $\ \, \mbox{\it \ } \mbox{\it \ }$
- ⑤ When mounted on 1 inch square 2 oz copper pad on 1.5x1.5 in. board of FR-4 material.

Revision History

TICVIOIOTI TIIOCOL		y				
Date		Comments				
	12/16/2013	• Updated ordering information to reflect the End-Of-life (EOL) of the mini-reel option (EOL notice #259)				
		Updated data sheet with new IR corporate template				
	3/12/2015	Updated package outline and tape and reel on pages 7 and 8.				



IR WORLD HEADQUARTERS: 101 N. Sepulveda Blvd., El Segundo, California 90245, USA To contact International Rectifier, please visit http://www.irf.com/whoto-call/

Submit Datasheet Feedback

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